

## Supplementary Information

# Atomic Oxygen Resistance of Polyimide Fibers with Phosphorus-Containing Side Chains

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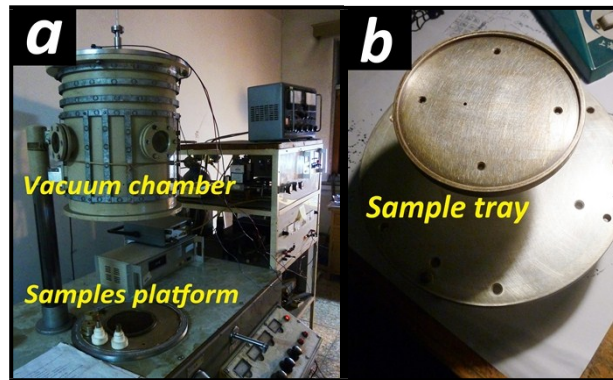
**Table S1.** Mass loss of PI fibers versus AO exposure with difference fluence.

No.	Diamine	SEM	Mass loss <sup>a</sup>	Mass loss	Mass loss	Mass loss	Mass loss	Mass loss
	Ratio	Images	8.3×10 <sup>19</sup>	1.4×10 <sup>20</sup>	2.0×10 <sup>20</sup>	2.6×10 <sup>20</sup>	3.4×10 <sup>20</sup>	5.0×10 <sup>20</sup>
	(m/n)	No.	atoms/cm <sup>2</sup>	atoms/cm <sup>2</sup>	atoms/cm <sup>2</sup>	atoms/cm <sup>2</sup>	atoms/cm <sup>2</sup>	atoms/cm <sup>2</sup>
			(mg/cm <sup>2</sup> )	(mg/cm <sup>2</sup> )	(mg/cm <sup>2</sup> )	(mg/cm <sup>2</sup> )	(mg/cm <sup>2</sup> )	(mg/cm <sup>2</sup> )
Kapton	--		0.35	0.60	0.85	1.15	1.45	2.10
PI-0	0/10	0-a ~ 0-e	0.35	0.55	0.80	1.00	1.20	1.80
PI-2	2/8	2-a ~ 2-e	0.35	0.45	0.60	0.90	1.15	1.40
PI-4	4/6	4-a ~ 4-e	0.35	0.45	0.60	0.70	0.80	1.05
PI-6	6/4	6-a ~ 6-e	0.25	0.30	0.35	0.50	0.60	0.75

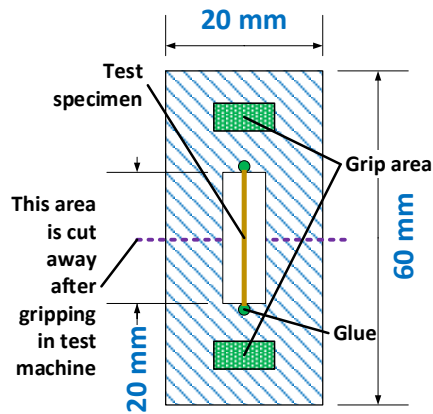
<sup>a</sup> Using formula (1) to calculate the total AO fluence with Kapton<sup>®</sup> film.

**Table S2.** Retention of tensile strength and Yong's modulus of the fibers after AO exposed at  $5.0 \times 10^{20}$  atoms/cm<sup>2</sup>.

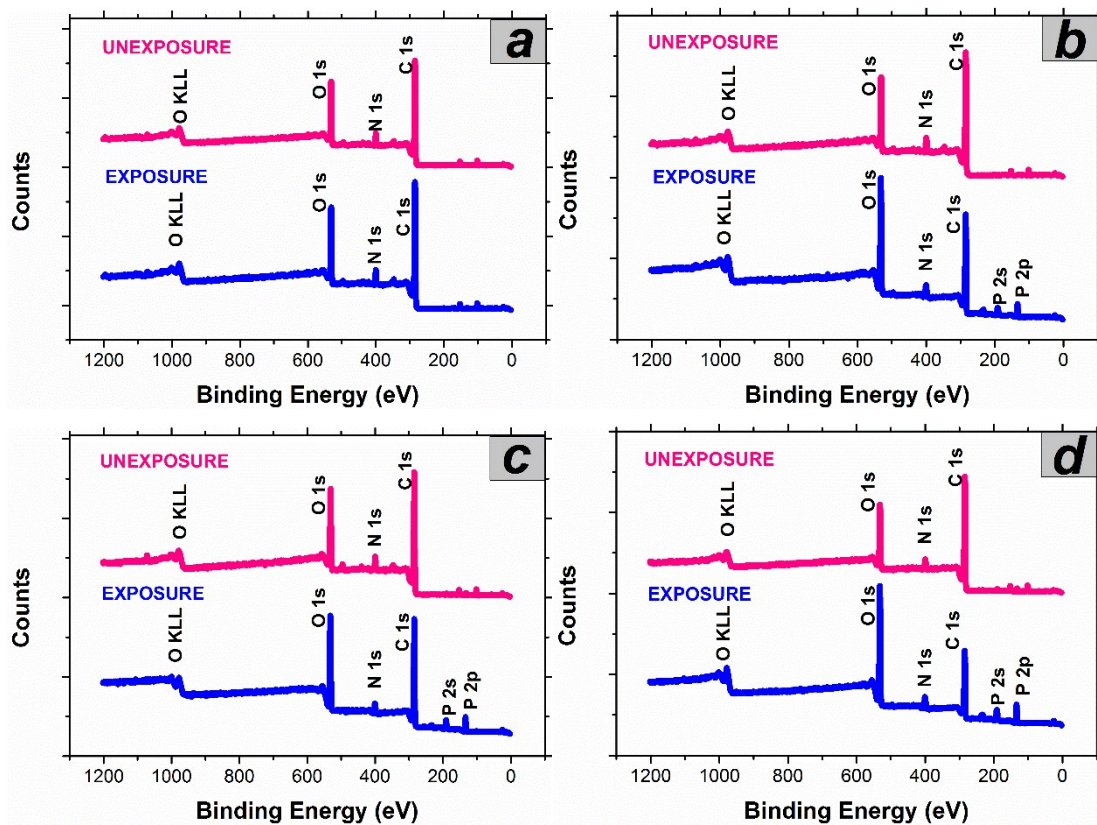
Item	Retention of tensile strength (%)	Retention of Yong's modulus (%)
PI-0	47.78	59.15
PI-2	49.91	65.31
PI-4	51.36	51.06
PI-6	64.87	66.04



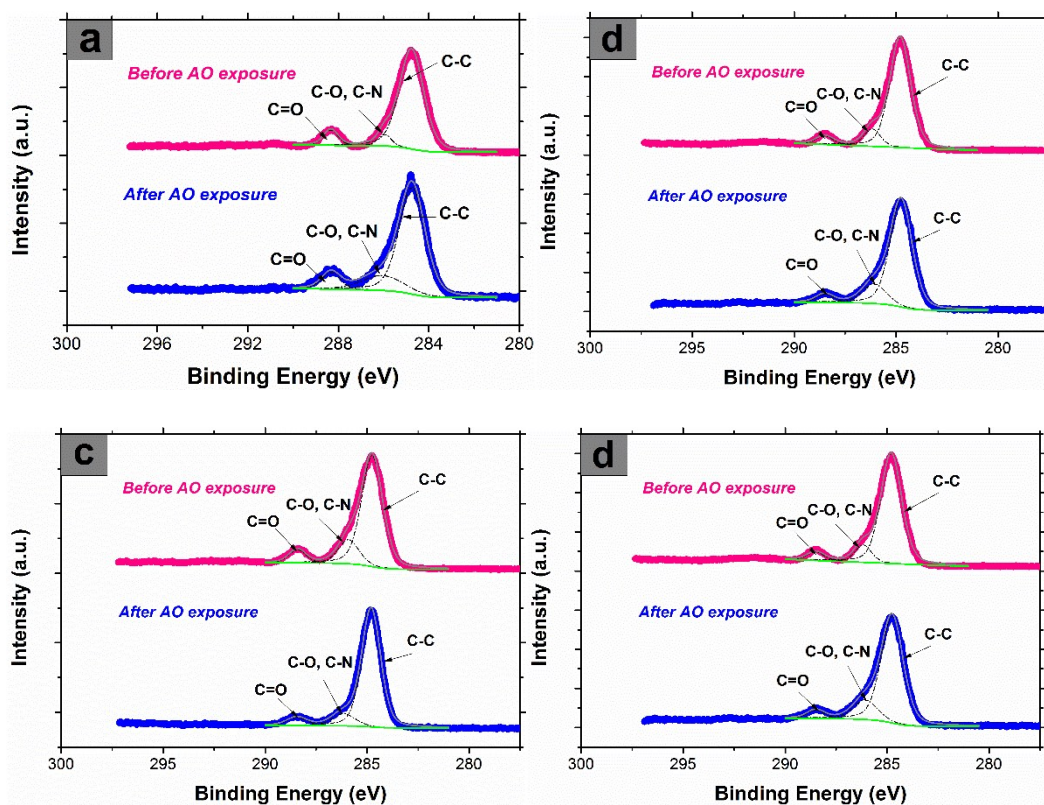
**Figure S1.** Ground-based AO effects simulation facility. (a) Vacuum chamber, (b) Sample tray.



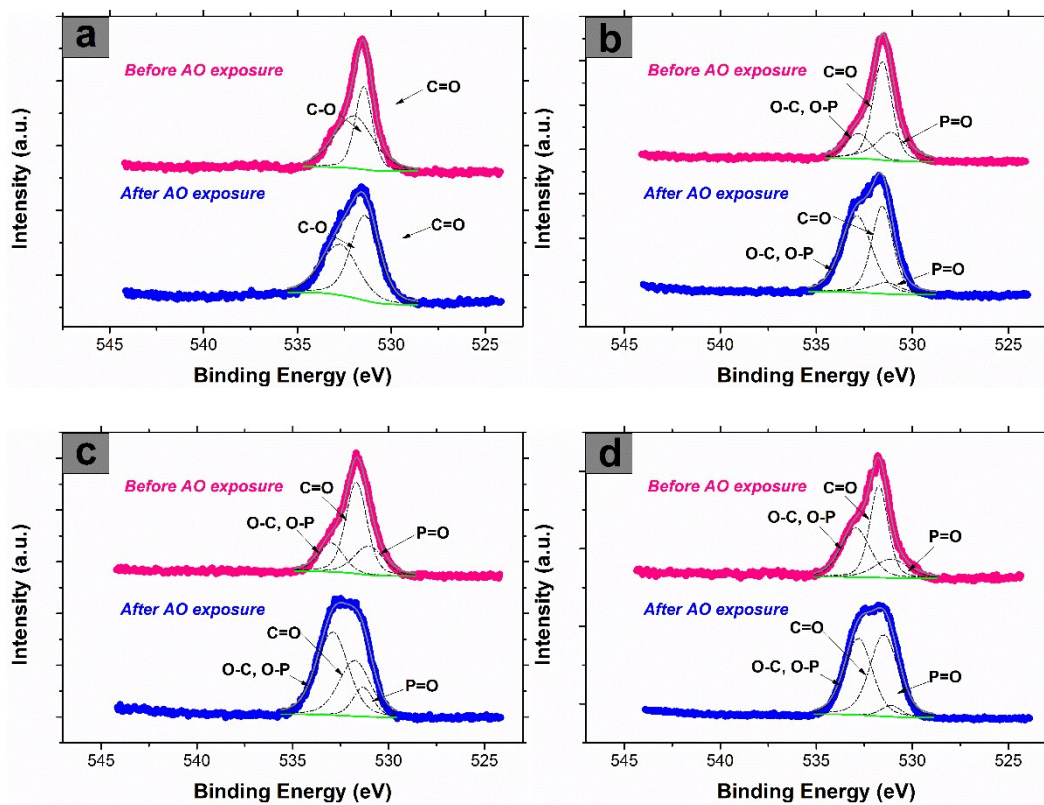
**Figure S2.** The schematic diagram of tensile testing for PI fiber.



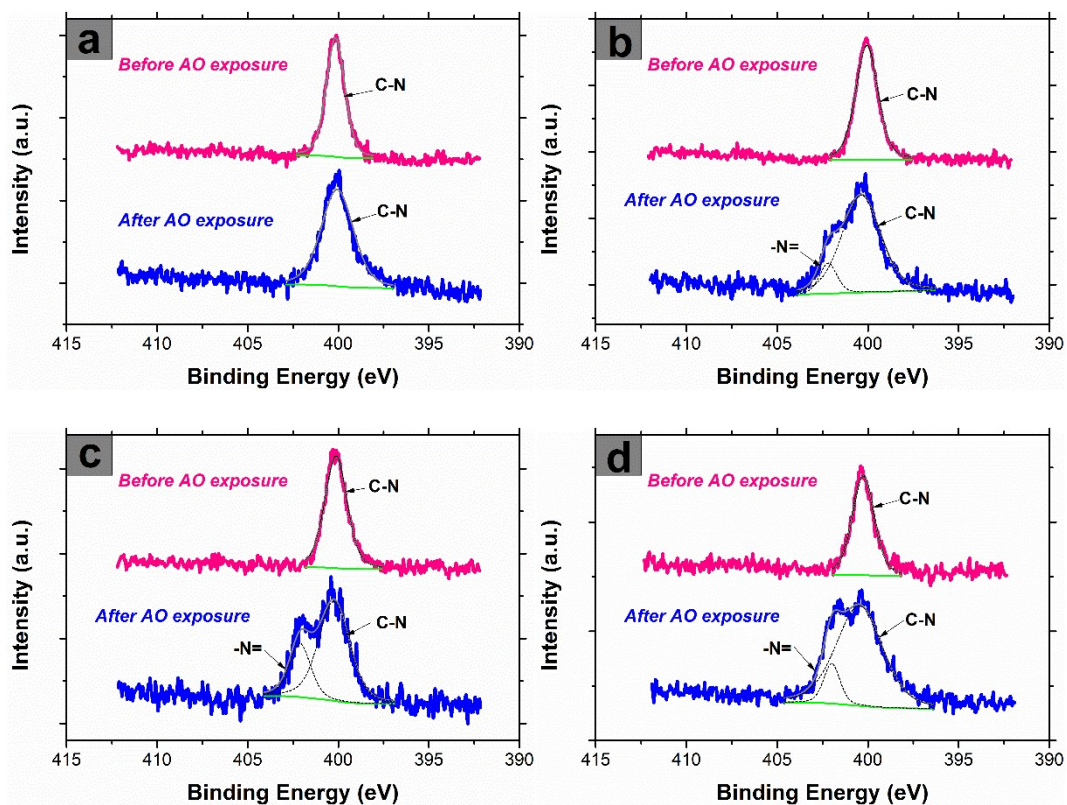
**Figure S3.** XPS survey spectra of fibers with and without AO exposure [a] PI-0, [b] PI-2, [c] PI-4, [d] PI-6.



**Figure S4.** High resolution XPS C 1s spectra of PI fibers before and after exposed to AO [a] PI-0, [b] PI-2, [c] PI-4, [d] PI-6.

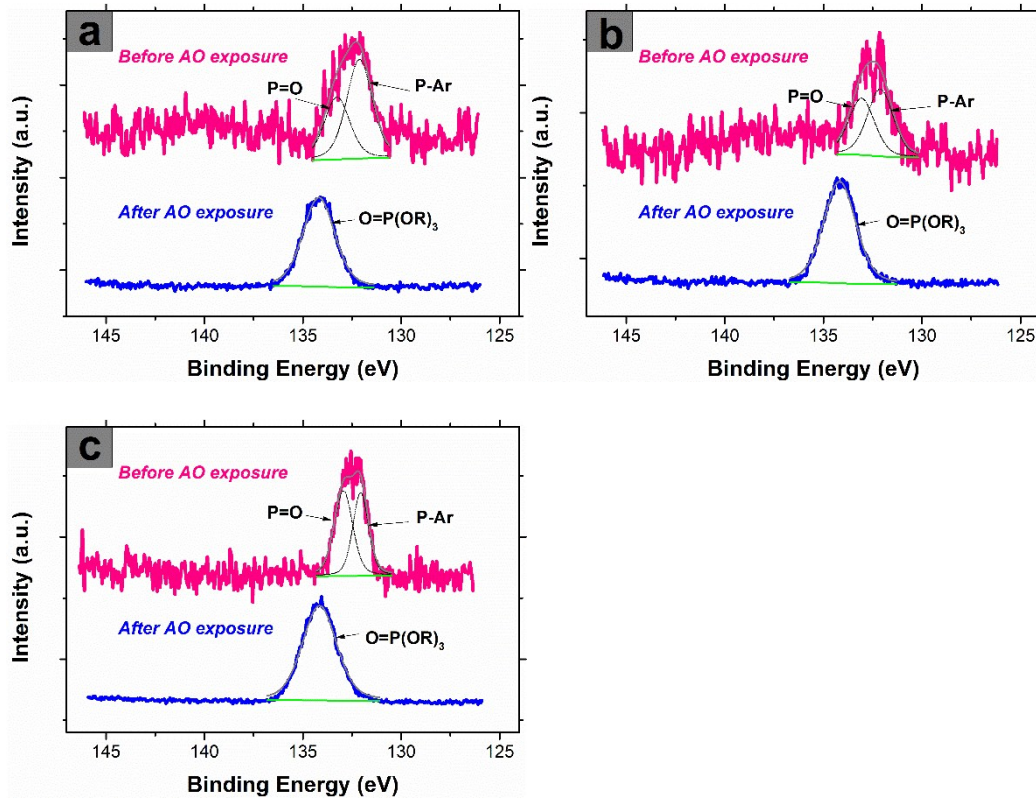


**Figure S5.** High resolution XPS O 1s spectra of PI fibers before and after exposed to AO [a] PI-0, [b] PI-2, [c] PI-4, [d] PI-6.



**Figure S6.** High resolution XPS N 1s spectra of PI fibers before and after exposed to AO [a] PI-0, [b] PI-2, [c] PI-4, [d] PI-6.





**Figure S7.** High resolution XPS P 2p spectra of PI fibers before and after exposed to AO [a] PI-2, [b] PI-4, [c] PI-6.